

SRAM Nonvolatile Controller Unit

Features

- ➤ Power monitoring and switching for 3-volt battery-backup applications
- ➤ Write-protect control
- ➤ 3-volt primary cell inputs
- ➤ Less than 10ns chip-enable propagation delay
- \blacktriangleright 5% or 10% supply operation

General Description

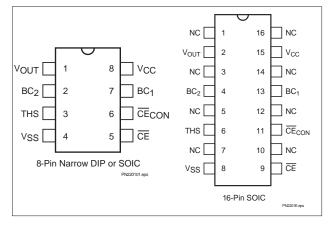
The CMOS bq2201 SRAM Nonvolatile Controller Unit provides all necessary functions for converting a standard CMOS SRAM into nonvolatile read/write memory.

A precision comparator monitors the $5V\ V_{CC}$ input for an out-of-tolerance condition. When out of tolerance is detected, a conditioned chip-enable output is forced inactive to write-protect any standard CMOS SRAM.

During a power failure, the external SRAM is switched from the $V_{\rm CC}$ supply to one of two 3V backup supplies. On a subsequent power-up, the SRAM is write-protected until a power-valid condition exists.

The bq2201 is footprint- and timing-compatible with industry standards with the added benefit of a chip-enable propagation delay of less than 10ns.

Pin Connections



Pin Names

V_{OUT} Supply output

BC₁—BC₂ 3-volt primary backup cell inputs

THS Threshold select input

CE chip-enable active low input

CECON Conditioned chip-enable output

V_{CC} +5-volt supply input

V_{SS} Ground

NC No Connect

Functional Description

An external CMOS static RAM can be battery-backed using the V_{OUT} and the conditioned chip-enable output pin from the bq2201. As $V_{\rm CC}$ slews down during a power failure, the conditioned chip-enable output $\overline{\rm CE}_{\rm CON}$ is forced inactive independent of the chip-enable input $\overline{\rm CE}$.

This activity unconditionally write-protects external SRAM as $V_{\rm CC}$ falls to an out-of-tolerance threshold $V_{\rm PFD}$. $V_{\rm PFD}$ is selected by the threshold select input pin, THS.

If THS is tied to $V_{SS},$ power-fail detection occurs at 4.62V typical for 5% supply operation. If THS is tied to $V_{CC},$ power-fail detection occurs at 4.37V typical for 10% supply operation. The THS pin must be tied to V_{SS} or V_{CC} for proper operation.

If a memory access is in process during power-fail detection, that memory cycle continues to completion before the memory is write-protected. If the memory cycle is not terminated within time t_{WPT} , the $\overline{\rm CE}_{\rm CON}$ output is unconditionally driven high, write-protecting the memory.

bq2201

As the supply continues to fall past V_{PFD} , an internal switching device forces V_{OUT} to one of the two external backup energy sources. $\overrightarrow{CE}_{CON}$ is held high by the V_{OUT} energy source.

During power-up, V_{OUT} is switched back to the V_{CC} supply as V_{CC} rises above the backup cell input voltage sourcing $V_{OUT}.$ The \overline{CE}_{CON} output is held inactive for time t_{CER} (120 ms maximum) after the supply has reached V_{PFD} , independent of the \overline{CE} input, to allow for processor stabilization.

During power-valid operation, the \overline{CE} input is fed through to the \overline{CE}_{CON} output with a propagation delay of less than 10ns. Nonvolatility is achieved by hardware hookup, as shown in Figure 1.

Energy Cell Inputs—BC₁, BC₂

Two primary backup energy source inputs are provided on the bq2201. The BC_1 and BC_2 inputs accept a 3V primary battery, typically some type of lithium chemistry. If no primary cell is to be used on either BC_1 or BC_2 , the unused input should be tied to V_{SS} .

If both inputs are used, during power failure the V_{OUT} output is fed only by BC_1 as long as it is greater than 2.5V. If the voltage at BC_1 falls below 2.5V, an internal isolation switch automatically switches V_{OUT} from BC_1 to BC_2 .

To prevent battery drain when there is no valid data to retain, V_{OUT} and \overline{CE}_{CON} are internally isolated from BC_1 and BC_2 by either of the following:

- Initial connection of a battery to BC₁ or BC₂, or
- Presentation of an isolation signal on \overline{CE} .

A valid isolation signal requires \overline{CE} low as V_{CC} crosses both V_{PFD} and V_{SO} during a power-down. See Figure 2. Between these two points in time, \overline{CE} must be brought to the point of (0.48 to 0.52)* V_{CC} and held for at least 700ns. The isolation signal is invalid if \overline{CE} exceeds 0.54* V_{CC} at any point between V_{CC} crossing V_{PFD} and V_{SO} .

The appropriate battery is connected to V_{OUT} and \overline{CE}_{CON} immediately on subsequent application and removal of V_{CC} .

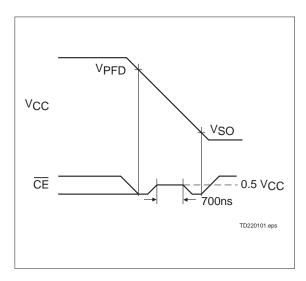


Figure 2. Battery Isolation Signal

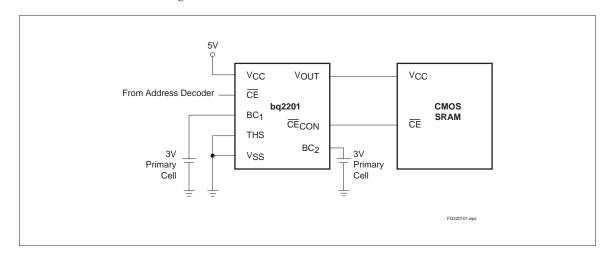


Figure 1. Hardware Hookup (5% Supply Operation)

Absolute Maximum Ratings

Symbol	Parameter	Value	Unit	Conditions
$V_{\rm CC}$	DC voltage applied on V_{CC} relative to $V_{\rm SS}$	-0.3 to 7.0	V	
V_{T}	DC voltage applied on any pin excluding $V_{\rm CC}$ relative to $V_{\rm SS}$	-0.3 to 7.0	V	$V_{\rm T} \le V_{\rm CC} + 0.3$
m		0 to +70	°C	Commercial
TOPR	perating temperature	-40 to +85	°C	Industrial "N"
T_{STG}	Storage temperature	-55 to +125	°C	
$T_{ m BIAS}$	Temperature under bias	-40 to +85	°C	
TSOLDER	Soldering temperature	260	°C	For 10 seconds
I _{OUT}	V _{OUT} current	200	mA	

Note:

Permanent device damage may occur if **Absolute Maximum Ratings** are exceeded. Functional operation should be limited to the Recommended DC Operating Conditions detailed in this data sheet. Exposure to conditions beyond the operational limits for extended periods of time may affect device reliability.

Recommended DC Operating Conditions (TA = TOPR)

Symbol	Parameter	Minimum	Typical	Maximum	Unit	Notes
37	C . l . lt	4.75	5.0	5.5	V	$\mathrm{THS} = \mathrm{V}_{\mathrm{SS}}$
$V_{\rm CC}$	Supply voltage	4.50	5.0	5.5	V	$\mathrm{THS} = \mathrm{V}_{\mathrm{CC}}$
V_{SS}	Supply voltage	0	0	0	V	
$V_{\rm IL}$	Input low voltage	-0.3	-	0.8	V	
V_{IH}	Input high voltage	2.2	-	$V_{\rm CC}$ + 0.3	V	
$egin{array}{c} V_{BC1}, \ V_{BC2} \end{array}$	Backup cell voltage	2.0	-	4.0	V	
THS	Threshold select	-0.3	-	$V_{\rm CC}$ + 0.3	V	

Note:

Typical values indicate operation at T_A = 25°C, V_{CC} = 5V or $V_{BC}.$

bq2201

DC Electrical Characteristics (TA = TOPR, VCC = 5V \pm 10%)

Symbol	Parameter	Minimum	Typical	Maximum	Unit	Conditions/Notes
I_{LI}	Input leakage current	-	-	± 1	μА	$V_{\rm IN}$ = $V_{\rm SS}$ to $V_{\rm CC}$
V _{OH}	Output high voltage	2.4	-	-	V	I _{OH} = -2.0mA
V_{OHB}	V _{OH} , BC supply	V _{BC} - 0.3	-	-	V	$V_{\rm BC} > V_{\rm CC},~I_{\rm OH} = -10\mu A$
V_{OL}	Output low voltage	-	-	0.4	V	$I_{\rm OL} = 4.0 { m mA}$
I_{CC}	Operating supply current	-	3	5	mA	No load on V_{OUT} and \overline{CE}_{CON} .
37	D 6 11 1 4 4 14	4.55	4.62	4.75	V	$\mathrm{THS} = \mathrm{V}_{\mathrm{SS}}$
V_{PFD}	Power-fail detect voltage	4.30	4.37	4.50	V	$THS = V_{CC}$
V_{SO}	Supply switch-over voltage	-	V_{BC}	-	V	
I_{CCDR}	Data-retention mode current	-	-	100	nA	$V_{\rm OUT}$ data-retention current to additional memory not included.
**	37	V _{CC} - 0.2	-	-	V	$V_{\rm CC} > V_{\rm BC}, I_{\rm OUT} = 100 {\rm mA}$
V _{OUT1}	V _{OUT} voltage	V _{CC} - 0.3	-	-	V	$V_{\rm CC} > V_{\rm BC}, I_{\rm OUT} = 160 \text{mA}$
V _{OUT2}	V _{OUT} voltage	V _{BC} - 0.3	-	-	V	$V_{CC} < V_{BC}, \ I_{OUT} = 100 \mu A$
37	Active backup cell	-	V_{BC2}	-	V	$V_{\mathrm{BC1}} < 2.5 \mathrm{V}$
V_{BC}	voltage	-	V_{BC1}	-	V	$V_{\rm BC1} > 2.5 { m V}$
I _{OUT1}	V _{OUT} current	-	-	160	mA	$V_{\rm OUT} > V_{\rm CC}$ - 0.3V
I _{OUT2}	V _{OUT} current	-	100	-	μА	$V_{\rm OUT} > V_{\rm BC}$ - 0.2V

Note: Typical values indicate operation at $T_A = 25$ °C, $V_{CC} = 5V$ or V_{BC} .

Capacitance (TA = 25° C, F = 1MHz, VCC = 5.0V)

Symbol	Parameter	Minimum	Typical	Maximum	Unit	Conditions
C_{IN}	Input capacitance	-	-	8	pF	Input voltage = 0V
Cout	Output capacitance	-	-	10	pF	Output voltage = 0V

Note: This parameter is sampled and not 100% tested.

AC Test Conditions

Parameter	Test Conditions
Input pulse levels	0V to 3.0V
Input rise and fall times	5ns
Input and output timing reference levels	1.5V (unless otherwise specified)
Output load (including scope and jig)	See Figure 3

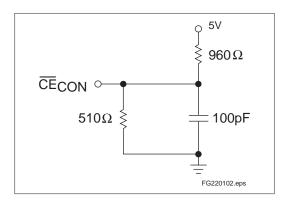


Figure 3. Output Load

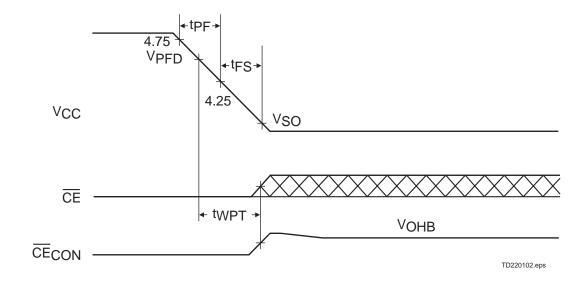
Power-Fail Control (TA = TOPR)

Symbol	Parameter	Minimum	Typical	Maximum	Unit	Notes
t_{PF}	V _{CC} slew, 4.75V to 4.25V	300	-	-	μs	
t_{FS}	$V_{\rm CC}$ slew, 4.25V to $V_{\rm SO}$	10	-	-	μs	
t_{PU}	$V_{\rm CC}$ slew, 4.25V to 4.75V	0	-	-	μs	
t_{CED}	Chip-enable propagation delay	-	7	10	ns	
tcer	Chip-enable recovery	40	80	120	ms	Time during which SRAM is write-protected after $V_{\rm CC}$ passes $V_{\rm PFD}$ on power-up.
$t_{ m WPT}$	Write-protect time	40	100	150	μs	Delay after V _{CC} slews down past V _{PFD} before SRAM is write-protected.

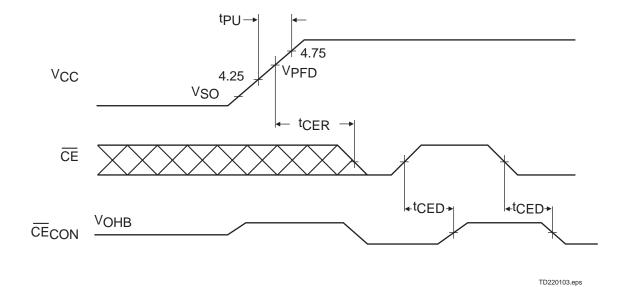
Note: Typical values indicate operation at T_A = 25°C.

Caution: Negative undershoots below the absolute maximum rating of -0.3V in battery-backup mode may affect data integrity.

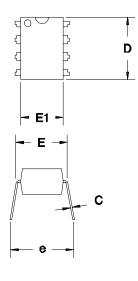
Power-Down Timing

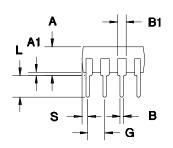


Power-Up Timing



8-Pin DIP Narrow (PN)



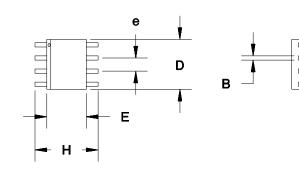


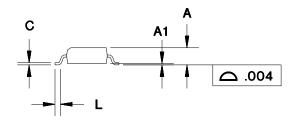
8-Pin DIP Narrow (PN)

Dimension	Minimum	Maximum	
A	0.160	0.180	
A1	0.015	0.040	
В	0.015	0.022	
B1	0.055	0.065	
C	0.008	0.013	
D	0.350	0.380	
E	0.300	0.325	
E1	0.230	0.280	
e	0.300	0.370	
G	0.090	0.110	
L	0.115	0.150	
S	0.020	0.040	

All dimensions are in inches.

8-Pin SOIC Narrow (SN)



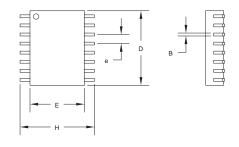


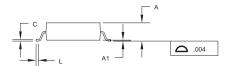
8-Pin SOIC Narrow (SN)

Dimension	Minimum	Maximum
A	0.060	0.070
A1	0.004	0.010
В	0.013	0.020
C	0.007	0.010
D	0.185	0.200
E	0.150	0.160
e	0.045	0.055
Н	0.225	0.245
L	0.015	0.035

All dimensions are in inches.

S: 16-Pin SOIC





16-Pin S (SOIC)

Dimension	Minimum	Maximum
A	0.095	0.105
A1	0.004	0.012
В	0.013	0.020
C	0.008	0.013
D	0.400	0.415
E	0.290	0.305
e	0.045	0.055
Н	0.395	0.415
L	0.020	0.040

All dimensions are in inches.

bq2201

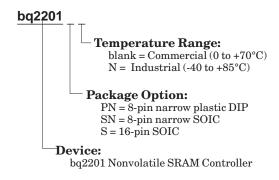
Data Sheet Revision History

Change No.	Page No.	Description	Nature of Change
1		Added industrial temperature range	
2	1, 3, 4	10% supply operation	Was: THS tied to $V_{\rm OUT}$ Is: THS tied to $V_{\rm CC}$
3	1, 9, 11	Added 16-pin package option	

Note:

Change 1 = Sept. 1991 B changes from Sept. 1990 A. Change 2 = Aug. 1997 C changes from Sept. 1991 B. Change 3 = Oct. 1998 D changes from Aug. 1997 C.

Ordering Information



www.ti.com 11-Nov-2025

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
BQ2201SN-N	Active	Production	SOIC (D) 8	75 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2201 -N
BQ2201SN-N.B	Active	Production	SOIC (D) 8	75 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2201 -N
BQ2201SN-NTR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2201 -N
BQ2201SN-NTR.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2201 -N
BQ2201SN-NTRG4	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2201 -N
BQ2201SN-NTRG4.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2201 -N

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PACKAGE OPTION ADDENDUM

www.ti.com 11-Nov-2025

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

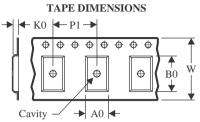
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Jul-2025

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

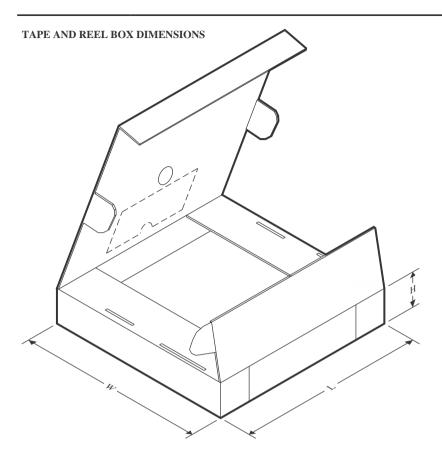


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ2201SN-NTR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
BQ2201SN-NTRG4	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Jul-2025



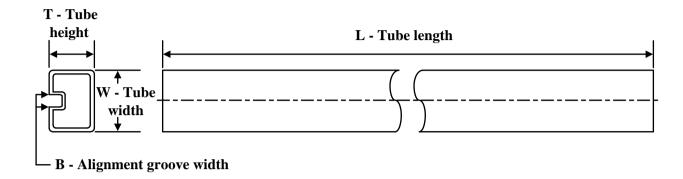
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ2201SN-NTR	SOIC	D	8	2500	353.0	353.0	32.0
BQ2201SN-NTRG4	SOIC	D	8	2500	353.0	353.0	32.0

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Jul-2025

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
BQ2201SN-N	D	SOIC	8	75	506.6	8	3940	4.32
BQ2201SN-N.B	D	SOIC	8	75	506.6	8	3940	4.32

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025